Search Notes

Application/Control No.	Applicant(s)/Patent und Reexamination	ler
10/727,602	TANAKA ET AL.	
Examiner	Art Unit	
Chun-Kuan (Mike) Lee	2181	

SEARCHED					
Class	Subclass	Date	Examiner		
710	8	8/31/2007	CKL		
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
710	8	8/31/2007	CKL	
710	15	8/31/2007	CKL	
710	18-19	8/31/2007	CKL	

(INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
Updated EAST search: US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT Updated Inventor search utilizing eDan and EAST	8/31/2007	CKL		
(710/8,15,18-19).ccls. limited text search	8/31/2007	CKL		
Non Patent Literature search utilizing INSPEC	8/31/2007	CKL		
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